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| U.S. Department of Commerce, Patent and Trademark Office | | | | Atty. Docket No. | | Serial No. | | |
| | | | | M-15282 US | | Not yet assigned | | |
| INFORMATION DISCLOSURE STATEMENT BY APPLICANT | | | | Applicant(s) | | | | |
| (Use several sheets if necessary) | | | | Steven E. Muentert | | | | |
| | | | | Filing Date | | Group 2878 | | |
| | | | | Herewith | | Not yet assigned | | |
| U.S. Patent Documents | | | | | | | | |
| *Examiner Initial | | Document Number | Date | Name | Class | Subclass | Filing Date If Appropriate | |
| | AA | | | | | | | |
| | AB | | | | | | | |
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| Foreign Patent Documents | | | | | | | | |
| | | | | | | | Translation | |
| | | Document | Date | Country | Class | Subclass | Yes | No |
| | AL | | | | | | | |
| | AM | | | | | | | |
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| | AO | | | | | | | |
| | AP | | | | | | | |
| OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) | | | | | | | | |
| BZ | AQ | "Interferometric Encoder Techniques", by R. J. Tansey et al., January 8, 1988, pages 1-52 | | | | | | |
| BZ | AR | "An Absolute Distance Interferometer Using A Dye Laser Heterodyne Interferometer And Spatial Separation Of Beams", Proceedings of SPIE - The International Society for Optical Engineering, Volume 429, Precision Surface Metrology, R. J. Tansey, August 23-24, 1983, pages 43-54 | | | | | | |
| BZ | AS | U.S. patent application entitled "Heterodyne Lateral Grating Interferometric Encoder", given serial number 10/394,930, filed on 03/19/2003 | | | | | | |
| Examiner | | Bue Lued | | Date Considered | | 8/10/05 | | |
| *EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant. | | | | | | | | |